


<b>Search Notes</b>  	<b>Application/Control No.</b>  10511549	<b>Applicant(s)/Patent Under Reexamination</b>  OHISHI ET AL.
	<b>Examiner</b>  Lisa J Hobbs	<b>Art Unit</b>  1657

### SEARCHED

Class	Subclass	Date	Examiner
	Text search performed.	27 March 2008	LJH

### SEARCH NOTES

Search Notes	Date	Examiner
Searched SEQ ID NOs: 2 and 4 in ABSS. Searches in SCORE.	27 March 2008	LJH
Searched EAST and STN, searches attached.	27 March 2008	LJH
Searched inventor names in eDAN.	27 March 2008	LJH
Consulted Y. Eyler, K. Carlson, and R. Wax on claim language and rejections.	27 March 2008	LJH
Updated searches with terms as previousl.y	27 Oct 2008	LJH

### INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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